

MOS FIELD EFFECT TRANSISTOR μ PA1723

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The μ PA1723 is N-Channel MOS Field Effect Transistor designed for power management switch.

FEATURES

· Low on-state resistance

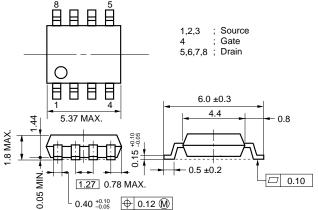
RDS(on)1 = $6.7 \text{ m}\Omega$ MAX. (VGS = 4.5 V, ID = 7.0 A)

 $R_{DS(on)2} = 7.4 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.0 \text{ V, Ip} = 7.0 \text{ A)}$

RDS(on)3 = $8.7 \text{ m}\Omega$ MAX. (VGS = 2.5 V, ID = 7.0 A)

- Low Ciss : Ciss = 3800 pF TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

PACKAGE DRAWING (Unit : mm) 8 5



ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1723G	Power SOP8

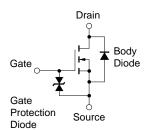
ABSOLUTE MAXIMUM RATINGS (TA = 25°C, All terminals are connected.)

V D33	20	V
Vgss	±12	V
$I_{D(DC)}$	±13	Α
ID(pulse)	±52	Α
Рт	2.0	W
Tch	150	°C
Tstg	-55 to + 150	°C
	ID(DC) ID(pulse) PT Tch	VGSS ±12 ID(DC) ±13 ID(pulse) ±52 PT 2.0 Tch 150

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

2. Mounted on ceramic substrate of 1200 mm² x 2.2mm

EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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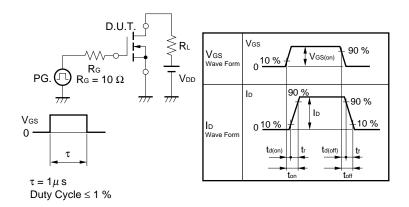


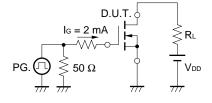
ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	V _{GS} = 4.5 V, I _D = 7.0 A		5.4	6.7	mΩ
2.a to course on state resistance	RDS(on)2	V _G S = 4.0 V, I _D = 7.0 A		5.5	7.4	mΩ
	RDS(on)3	V _G S = 2.5 V, I _D = 7.0 A		6.5	8.7	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	0.5	0.9	1.5	V
Forward Transfer Admittance	Vfs	V _{DS} = 10 V, I _D = 7.0 A	15.0	32	1.0	S
Drain Leakage Current	Ipss	V _{DS} = 20 V, V _{GS} = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	V _{GS} = ±12 V, V _{DS} = 0 V			±10	μΑ
Input Capacitance	Ciss	V _{DS} = 10 V		3800		pF
Output Capacitance	Coss	V _{GS} = 0 V		1200		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		700		pF
Turn-on Delay Time	td(on)	ID = 7.0 A		70		ns
Rise Time	t r	V _{GS(on)} = 4.5 V		440		ns
Turn-off Delay Time	t _{d(off)}	V _{DD} = 10 V		230		ns
Fall Time	t f	R _G = 10 Ω		300		ns
Total Gate Charge	Q _G	ID = 13 A		47.0		nC
Gate to Source Charge	Qgs	V _{DD} = 16 V		11.0		nC
Gate to Drain Charge	Q _{GD}	Vcs = 4.5 V		12.0		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 13.0 A, VGS = 0 V		0.75		V
Reverse Recovery Time	trr	IF = 13.0 A, VGS = 0 V		68		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		70		nC

TEST CIRCUIT 1 SWITCHING TIME

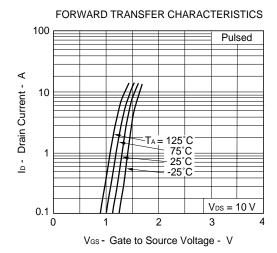
TEST CIRCUIT 2 GATE CHARGE

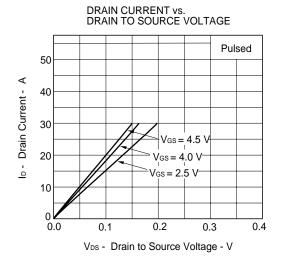


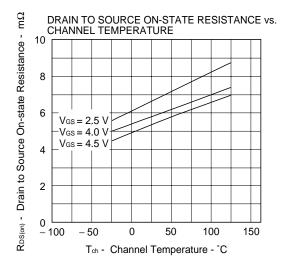


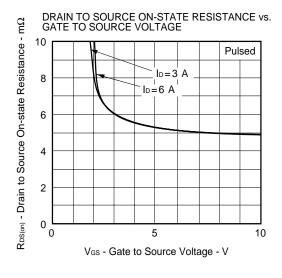


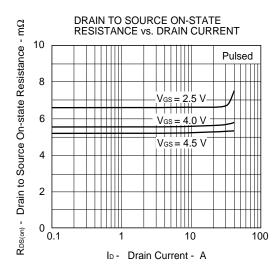
TYPICAL CHARACTERISTICS (TA = 25°C)

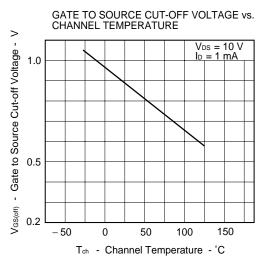


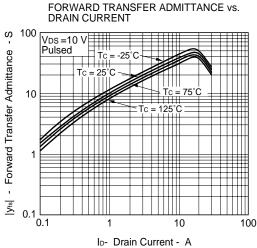


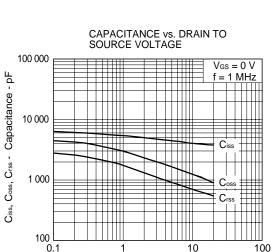






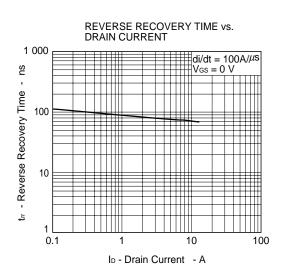


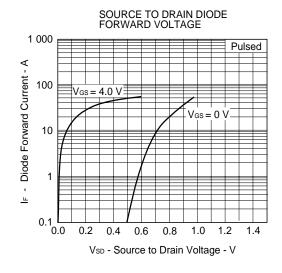


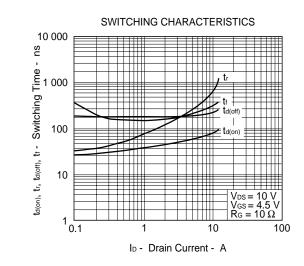


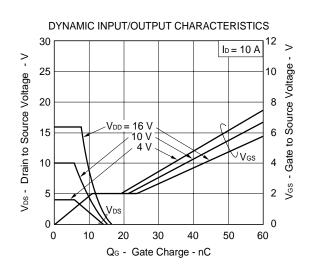
Remark Mounted on ceramic substrate of 1200 mm^2 x 2.2 mm

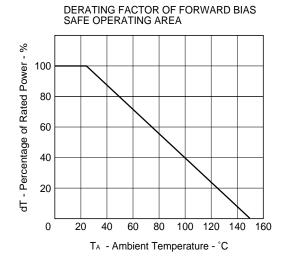
V_{DS} - Drain to Source Voltage - V

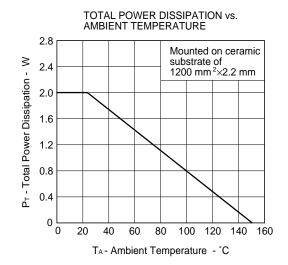




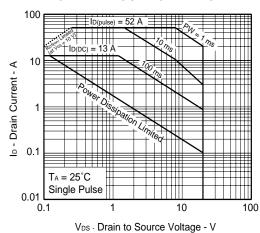






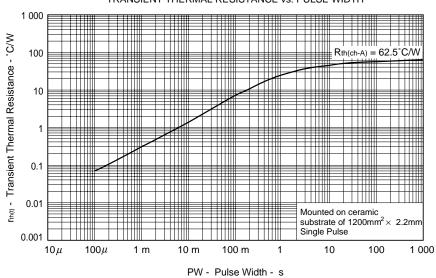


★ FORWARD BIAS SAFE OPERATING AREA



RemarkMounted on ceramic substrate of 1200 mm² x 2.2 mm

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



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 μ PA1723



[MEMO]

NEC μ PA1723

[MEMO]

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